

SiC

Silicon Carbide Diode

2nd Generation thinQ!™

2nd Generation thinQ!™ SiC Schottky Diode
IDY15S120

Data Sheet

Rev. 2.1, 2011-05-25
Final

Industrial & Multimarket

2nd Generation thinQ!™ SiC Schottky Diode

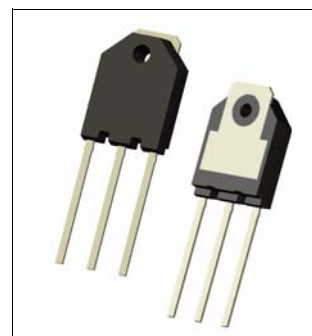
IDY15S120

1 Description

The second generation of Infineon SiC Schottky diodes has emerged over the years as the industry standard. The IDYxxS120 products are extending the already broad portfolio with the new TO-247HC (high creepage) package.

The new package layout is fully compatible with the industry standard TO247, and can therefore easily be placed in already existing designs, with no extra efforts.

The higher creepage distance increases the safety margin against the risk of short circuits, especially arcing, which might be triggered by the presence of dust or dirt inside the system. This reduces the need of additional chemical (silicone gel or creams) or mechanical (sheaths or foils) solutions to lower the pollution level between the leads, with all consequent benefits of a lean and faster manufacturing process



Features

- Revolutionary semiconductor material - Silicon Carbide
- Switching behavior benchmark
- No reverse recovery/ No forward recovery
- Temperature independent switching behavior
- High surge current capability
- Pb-free lead plating; RoHS compliant
- Qualified according to JEDEC¹⁾ for target applications
- Optimized for high temperature operation



Benefits

- System efficiency improvement over Si diodes
- System cost / size savings due to reduced cooling requirements
- Enabling higher frequency / increased power density solutions
- Higher system reliability due to lower operating temperatures and less fans
- Package design with high creepage distance
- Reduced EMI

Applications

- Solar applications; UPS; Motor Drives;
- SMPS e.g.; CCM PFC

Table 1 Key Performance Parameters

Parameter	Value	Unit
V_{DC}	1200	V
Q_C	54	nC
$I_F @ T_C < 150^\circ C$	15	A

Table 2 Pin Definition

Pin 1	Pin2	Pin 3
A	C	A



Type / Ordering Code	Package	Marking	Related Links
IDY15S120	PG-TO247HC-3	D15S120	IFX SiC Diodes Webpage

1) J-STD20 and JESD22

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2 Maximum ratings

Table 3 Maximum ratings

Parameter	Symbol	Values (leg/device)			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Continuous forward current	I_F	-	-	7.5/15	A	$T_C = < 150^\circ\text{C}$
Surge non-repetitive forward current, sine halfwave	$I_{F, SM}$	-	-	39/78		$T_C = 25^\circ\text{C}, t_p = 10 \text{ ms}$
		-	-	33/66		$T_C = 150^\circ\text{C}, t_p = 10 \text{ ms}$
Non-repetitive peak forward current	$I_{F, max}$	-	-	150/300		$T_C = 25^\circ\text{C}, t_p = 10 \mu\text{s}$
$i^2 t$ value	$\int i^2 dt$	-	-	10/40	A^2s	$T_C = 25^\circ\text{C}, t_p = 10 \text{ ms}$
		-	-	6/26		$T_C = 150^\circ\text{C}, t_p = 10 \text{ ms}$
Repetitive peak reverse voltage	V_{RRM}	-	-	1200	V	$T_J = 25^\circ\text{C}$
Diode dv/dt ruggedness	dv/dt	-	-	50	V/ns	$V_R = 0 \dots 960 \text{ V}$
Power dissipation	P_{tot}	-	-	100/175	W	$T_C = 25^\circ\text{C}$
Operating and storage temperature	T_j, T_{stg}	-55	-	150	$^\circ\text{C}$	
Mounting torque		-	-	0.6	Ncm	M3 screws Maximum of mounting processes:3

3 Thermal characteristics

Table 4 Thermal characteristics

Parameter	Symbol	Values (leg/device)			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Thermal resistance, junction - case	R_{thJC}	-	-	1.5/0.9	K/W	
Thermal resistance, junction - ambient	R_{thJA}	-	-	40		leaded
Soldering temperature, wavesoldering only allowed at leads	T_{sold}	-	-	260	$^\circ\text{C}$	1.6 mm (0.063 in.) from case for 10 s

4 Electrical characteristics

Electrical characteristics, at $T_j=25\text{ °C}$, unless otherwise specified.

Table 5 Static characteristics

Parameter	Symbol	Values (leg/device)			Unit	Note / Test Condition
		Min.	Typ.	Max.		
DC blocking voltage	V_{DC}	1200	-	-	V	$T_j = 25\text{ °C}$, $I_R = 0.1\text{ mA}$
Diode forward voltage	V_F	-	1.65	1.8		$I_F = 10\text{ A}$, $T_j = 25\text{ °C}$
		-	2.55			$I_F = 10\text{ A}$, $T_j = 150\text{ °C}$
Reverse current	I_R	-	7.5/15	180/360	μA	$I_R = 1200\text{ V}$, $T_j = 25\text{ °C}$
		-	30/60	750/1500		$I_R = 1200\text{ V}$, $T_j = 150\text{ °C}$

Table 6 AC characteristics

Parameter	Symbol	Values (leg/device)			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Total capacitive charge	Q_c	-	27/54	-	nC	$V_R = 400\text{ V}$, $F \leq F_{\max}$
Switching time ¹⁾	t_c	-	-	<10	ns	$di_F/dt = 200\text{ A}/\mu\text{s}$, $T_j = 150\text{ °C}$
	C	-	375/750	-	pF	$V_R = 1\text{ V}$, $f = 1\text{ MHz}$
		-	30/60	-		$V_R = 300\text{ V}$, $f = 1\text{ MHz}$
		-	27/54	-		$V_R = 600\text{ V}$, $f = 1\text{ MHz}$

1) t_c is the time constant for the capacitive displacement current waveform (independent from T_j , I_{LOAD} and di/dt), different from t_{rr} which is dependent on T_j , I_{LOAD} and di/dt . No reverse recovery time constant t_{rr} due to absence of minority carrier injection.

5 Electrical characteristics diagrams

Electrical characteristics, at $T_j=25\text{ °C}$, unless otherwise specified.

Table 7

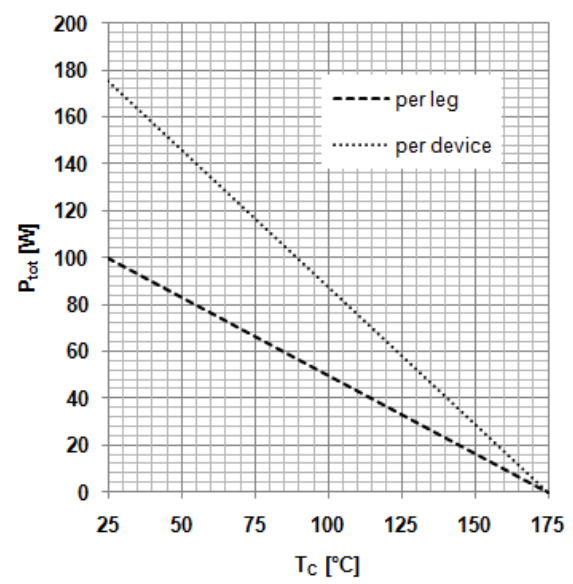
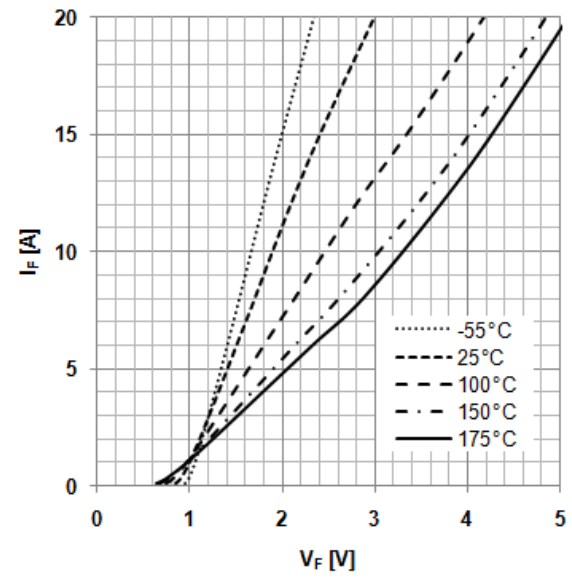
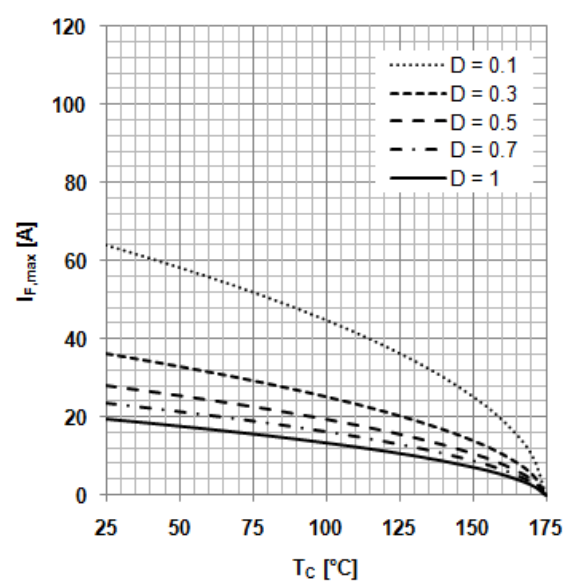
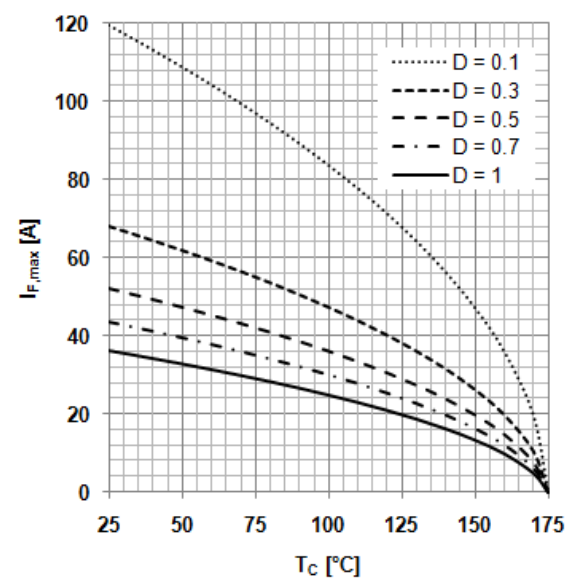
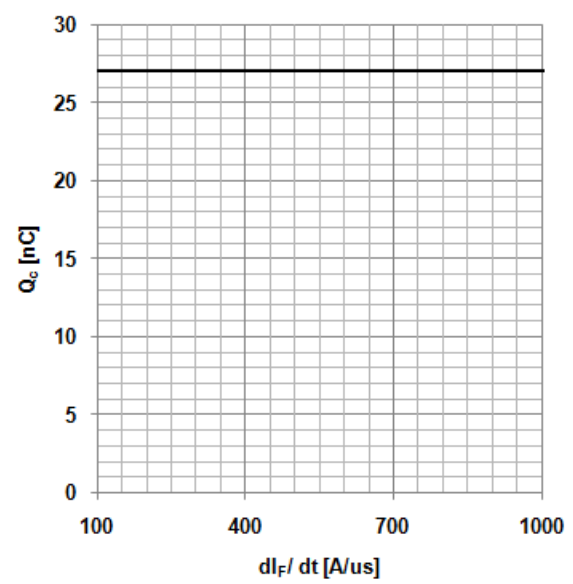
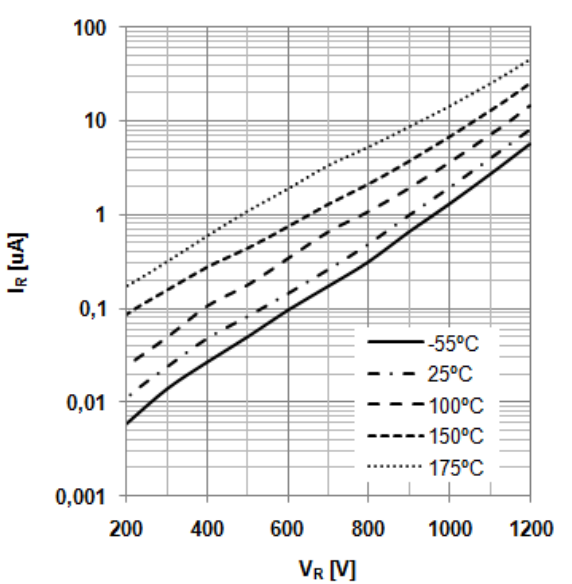
Power dissipation	Typ. forward characteristic (per leg)
	
$P_{\text{tot}} = f(T_c)$; parameter: $R_{\text{thJC(max)}}$	$I_F = f(V_F)$; $t_p = 400\text{ }\mu\text{s}$; parameter: T_j ; $I_F = f(T_c)$; per device the values double

Table 8

Diode forward current (per leg)	Diode forward current (per device)
	
$T_j \leq 175\text{ °C}$; parameter: $R_{\text{thJC(max)}}$; $V_F(\text{max})$; $D = t_p / T$	$T_j \leq 175\text{ °C}$; parameter: $R_{\text{thJC(max)}}$; $V_F(\text{max})$; $D = t_p / T$

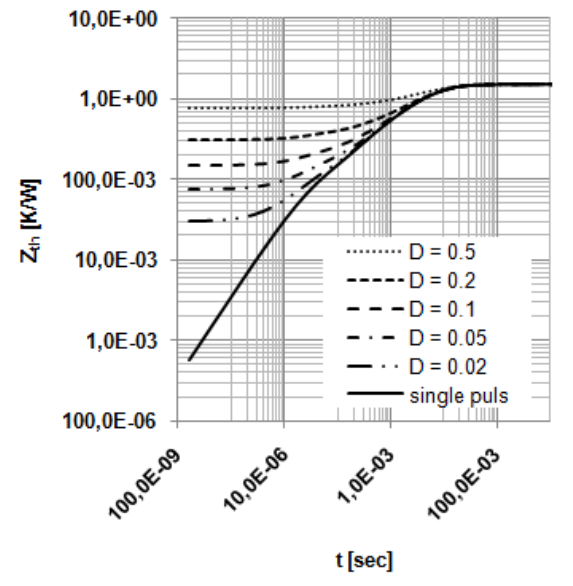
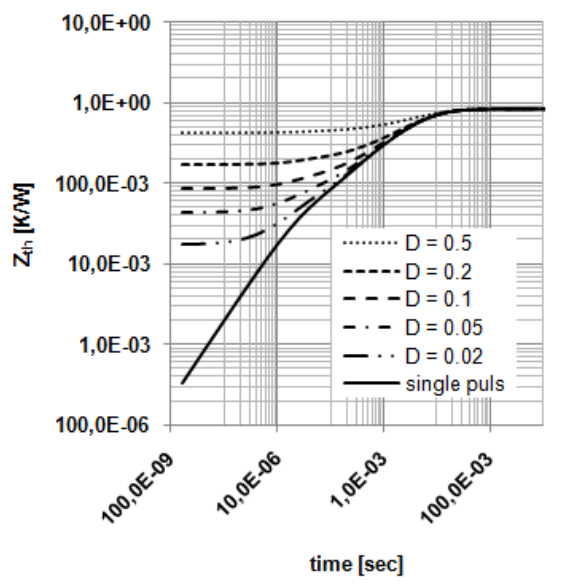
Electrical characteristics diagrams

Table 9

Typ. capacitance charge vs. current slope ¹⁾ (per leg)	Typ. reverse current vs. reverse voltage (per leg)
	
$Q_D = f(dI_F/dt)4$; $T_j = 150\text{ °C}$; $I_F \leq I_{F\text{ max}}$ per device the values double	$I_R = f(V_R)$; parameter: T_j ; per device the values double

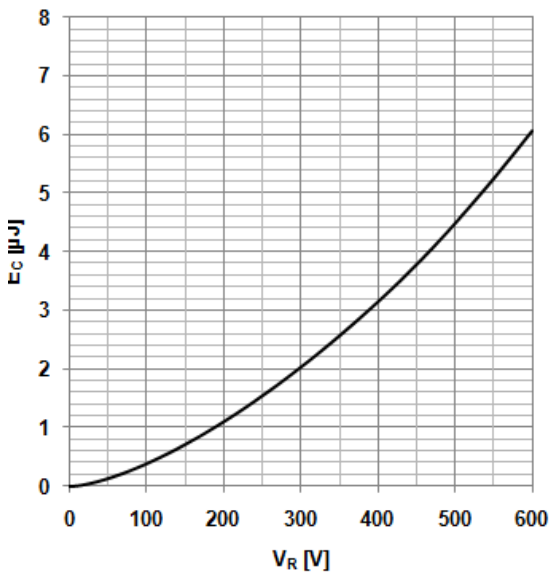
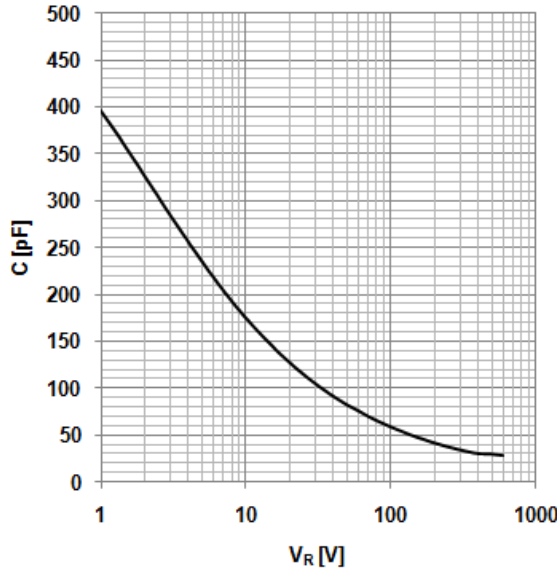
1) Only capacitive charge occurring, guaranteed by design

Table 10

Typ. transient thermal impedance (per leg)	Typ. transient thermal impedance (per device)
	
$Z_{thjc} = f(t_p)$; parameter: $D = t_p / T$	$Z_{thjc} = f(t_p)$; parameter: $D = t_p / T$

Electrical characteristics diagrams

Table 11

Typ. C stored energy (per leg)	Typ. capacitance vs. reverse voltage (per leg)
	
$E_C = f(V_R)$; per device the values double	$C = f(V_R)$; $T_C = 25\text{ °C}$, $f = 1\text{ MHz}$; per device the values double

6 Package outlines

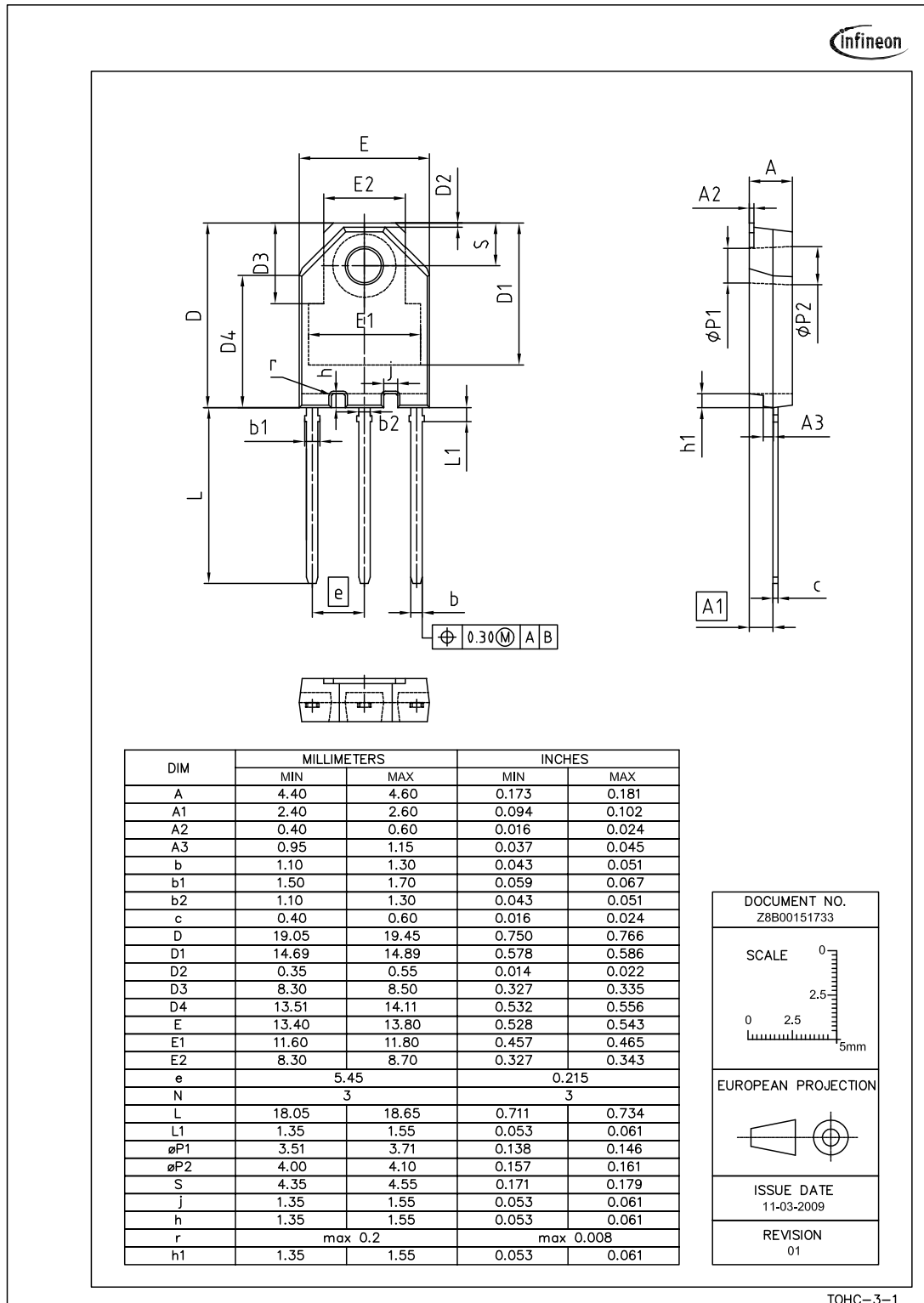


Figure 1 Dimensions in mm/inches

7 Revision History

2nd Generation thinQ!™ 2nd Generation thinQ!™ SiC Schottky Diode

Revision History: 2011-05-25, Rev. 2.1

Previous Revision:

Revision	Subjects (major changes since last revision)
2.0	Release of final data sheet
2.1	Update of Total capacitive charge

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